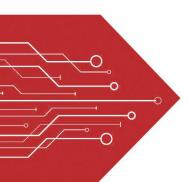
## MSKSEMI















**ESD** 

TVS

TSS

MOV

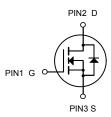
GDT

**PLED** 

# Broduct data sheet







N-Channel MOSFET

TO-252

#### **Description**

The AOD4130-MS uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

 $V_{DS} = 60V I_{D} = 30 A$ 

 $R_{DS(ON)}$  < 30m $\Omega$  @  $V_{GS}$ =10V

#### **Application**

Battery protection

Load switch

Uninterruptible power supply

#### Absolute Maximum Ratings (T<sub>C</sub>=25°Cunless otherwise noted)

| Symbol                                | Symbol Parameter                                                 |      | Units |  |
|---------------------------------------|------------------------------------------------------------------|------|-------|--|
| Vos                                   | Drain-Source Voltage 60                                          |      | V     |  |
| Vgs                                   | Gate-Source Voltage ±20                                          |      | V     |  |
| I <sub>D</sub> @T <sub>C</sub> =25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>     | 30   | А     |  |
| I <sub>D</sub> @T <sub>C</sub> =100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>     | 15   | А     |  |
| I <sub>D</sub> @T <sub>A</sub> =25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> 5.6 |      | А     |  |
| I <sub>D</sub> @T <sub>A</sub> =70°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> 4.5 |      | А     |  |
| Ірм                                   | Pulsed Drain Current <sup>2</sup> 46                             |      | А     |  |
| EAS                                   | Single Pulse Avalanche Energy <sup>3</sup>                       | 25.5 | mJ    |  |
| las                                   | Avalanche Current                                                | 22.6 | А     |  |
| P <sub>D</sub> @T <sub>C</sub> =25°C  | Total Power Dissipation <sup>4</sup>                             |      | W     |  |
| P <sub>D</sub> @T <sub>A</sub> =25°C  | Total Power Dissipation <sup>4</sup> 2                           |      | W     |  |
| Тѕтс                                  | Storage Temperature Range -55 to 150                             |      | °C    |  |
| TJ                                    | Operating Junction Temperature Range -55 to 150                  |      | °C    |  |



| Reja | Thermal Resistance Junction-Ambient <sup>1</sup> | 62  | °C/W |
|------|--------------------------------------------------|-----|------|
| Rejc | Thermal Resistance Junction-Case <sup>1</sup>    | 3.6 | °C/W |

#### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

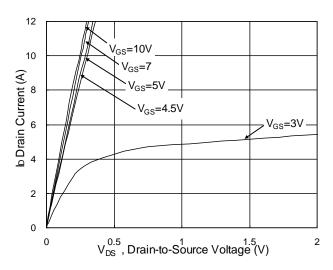
| Symbol                 | Parameter                                      | Conditions                                                         | Min. | Тур.  | Max. | Unit  |
|------------------------|------------------------------------------------|--------------------------------------------------------------------|------|-------|------|-------|
| BVDSS                  | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V , I <sub>D</sub> =250uA                        | 60   |       |      | V     |
| △BVbss/△TJ             | BV <sub>DSS</sub> Temperature Coefficient      | Reference to 25°C , I <sub>D</sub> =1mA                            |      | 0.063 |      | V/°C  |
| _                      |                                                | V <sub>GS</sub> =10V , I <sub>D</sub> =15A                         |      | 25    | 30   |       |
| RDS(ON)                | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =4.5V , I <sub>D</sub> =10A                        |      | 30    | 38   | mΩ    |
| V <sub>GS</sub> (th)   | Gate Threshold Voltage                         | V V 1 050 A                                                        | 1.2  |       | 2.5  | V     |
| $\triangle V_{GS(th)}$ | V <sub>GS(th)</sub> Temperature Coefficient    | —V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA          |      | -5.24 |      | mV/°C |
| l                      | Dunin Course Leakens Cument                    | V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C  |      |       | 1    |       |
| IDSS                   | Drain-Source Leakage Current                   | V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C  |      |       | 5    | uA    |
| Igss                   | Gate-Source Leakage Current                    | $V_{GS}$ = $\pm 20V$ , $V_{DS}$ = $0V$                             |      |       | ±100 | nA    |
| gfs                    | Forward Transconductance                       | V <sub>DS</sub> =5V , I <sub>D</sub> =15A                          |      | 17    |      | S     |
| Rg                     | Gate Resistance                                | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz                 |      | 3.2   |      | Ω     |
| Qg                     | Total Gate Charge (4.5V)                       |                                                                    |      | 12.6  |      |       |
| Q <sub>gs</sub>        | Gate-Source Charge                             | V <sub>DS</sub> =48V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =12A |      | 3.2   |      | nC    |
| Q <sub>gd</sub>        | Gate-Drain Charge                              |                                                                    |      | 6.3   |      |       |
| Td(on)                 | Turn-On Delay Time                             |                                                                    |      | 8     |      |       |
| Tr                     | Rise Time                                      | V <sub>DD</sub> =30V , V <sub>GS</sub> =10V ,                      |      | 14.2  |      |       |
| Td(off)                | Turn-Off Delay Time                            | R <sub>G</sub> =3.3 ,<br>I <sub>D</sub> =10A                       |      | 24.4  |      | ns    |
| T <sub>f</sub>         | Fall Time                                      |                                                                    |      | 4.6   |      |       |
| Ciss                   | Input Capacitance                              |                                                                    |      | 1378  |      |       |
| Coss                   | Output Capacitance                             | V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz                |      | 86    |      | pF    |
| Crss                   | Reverse Transfer Capacitance                   |                                                                    |      | 64    |      |       |
| Is                     | Continuous Source Current <sup>1,5</sup>       | W W 5 5                                                            |      |       | 23   | Α     |
| Іѕм                    | Pulsed Source Current <sup>2,5</sup>           | −V <sub>G</sub> =V <sub>D</sub> =0V , Force Current                |      |       | 46   | Α     |
| VsD                    | Diode Forward Voltage <sup>2</sup>             | V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C    |      |       | 1.2  | V     |

#### Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%
- 3.The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1mH,IAS=22.6A
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.



#### **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

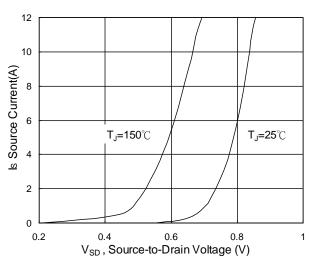


Fig.3 Forward Characteristics of Reverse

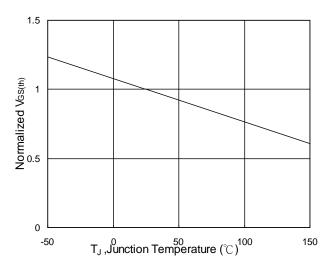


Fig.5 Normalized  $V_{GS(th)}$  v.s  $T_J$ 

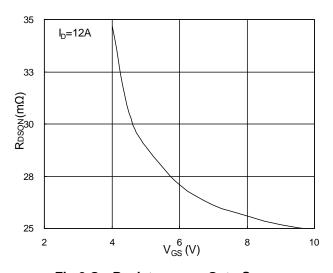


Fig.2 On-Resistance v.s Gate-Source

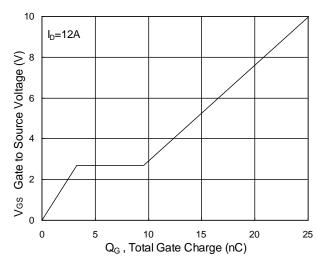


Fig.4 Gate-Charge Characteristics

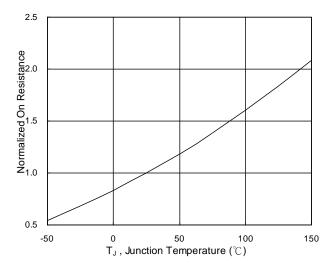
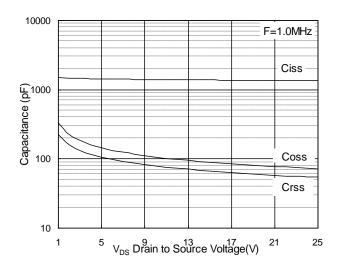


Fig.6 Normalized  $R_{DSON}$  v.s  $T_J$ 

AOD4130-MS HF &





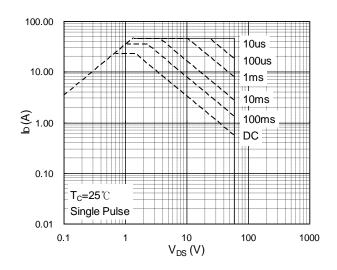


Fig.7 Capacitance

Fig.8 Safe Operating Area

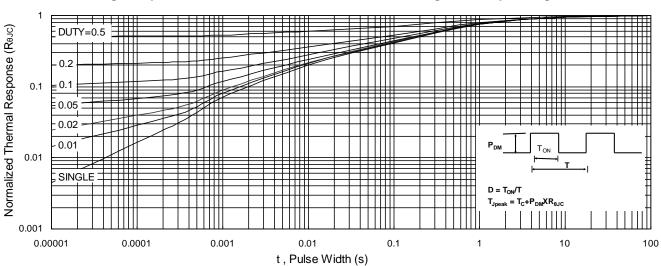


Fig.9 Normalized Maximum Transient Thermal Impedance

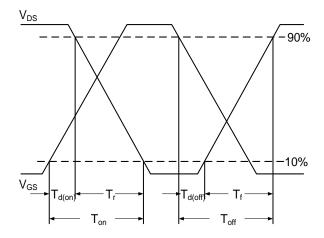


Fig.10 Switching Time Waveform

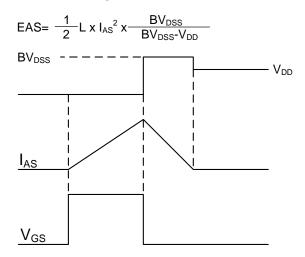
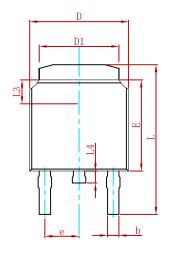
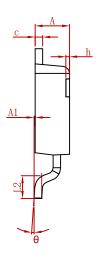


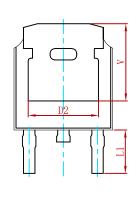
Fig.11 Unclamped Inductive Waveform



#### **PACKAGE MECHANICAL DATA**

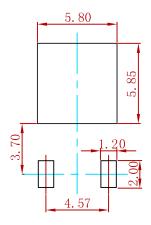






| 0      | Dimensions In Millimeters |        | Dimension | s In Inches |
|--------|---------------------------|--------|-----------|-------------|
| Symbol | Min.                      | Max.   | Min.      | Max.        |
| Α      | 2.200                     | 2.400  | 0.087     | 0.094       |
| A1     | 0.000                     | 0.127  | 0.000     | 0.005       |
| b      | 0.635                     | 0.770  | 0.025     | 0.030       |
| С      | 0.460                     | 0.580  | 0.018     | 0.023       |
| D      | 6.500                     | 6.700  | 0.256     | 0.264       |
| D1     | 5.100                     | 5.460  | 0.201     | 0.215       |
| D2     | 4.830                     | REF.   | 0.190     | REF.        |
| Е      | 6.000                     | 6.200  | 0.236     | 0.244       |
| е      | 2.186                     | 2.386  | 0.086     | 0.094       |
| L      | 9.712                     | 10.312 | 0.382     | 0.406       |
| L1     | 2.900                     | REF.   | 0.114     | REF.        |
| L2     | 1.400                     | 1.700  | 0.055     | 0.067       |
| L3     | 1.600                     | REF.   | 0.063     | REF.        |
| L4     | 0.600                     | 1.000  | 0.024     | 0.039       |
|        |                           |        |           |             |
| θ      | 0°                        | 8°     | 0°        | 8°          |
| h      | 0.000                     | 0.300  | 0.000     | 0.012       |
| V      | 5.250                     | REF.   | 0.207     | REF.        |

### **Suggested Pad Layout**



#### Note:

- 1. Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

| P/N        | PKG    | QTY  |
|------------|--------|------|
| AOD4130-MS | TO-252 | 2500 |



Semiconductor Compiance

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